


<b>Search Notes</b> 	<b>Application/Control No.</b> 09467210	<b>Applicant(s)/Patent Under Reexamination</b> KWON ET AL.
	<b>Examiner</b> Tran, Hai	<b>Art Unit</b> 2623

SEARCHED			
Class	Subclass	Date	Examiner
348	552	05/09/2007	HVT

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
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